## **RSC Advances**



## **PAPER**

View Article Online
View Journal | View Issue



Cite this: RSC Adv., 2022, 12, 12344

# transitions in magnetite Fe<sub>3</sub>O<sub>4</sub> nanoparticles†

Unusual semiconductor-metal-semiconductor

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Magnetite ( $Fe_3O_4$ ) nanoparticles were successfully prepared by a co-precipitation method. Rietveld refinement on the X-ray diffraction pattern confirmed the development of a single-phase cubic spinel structure with space group  $Fd\bar{3}m$ . However,  $^{57}Fe$  Mössbauer spectroscopy suggested the presence of  $Fe^{3+}$  and  $Fe^{2.5+}$  (mixed  $Fe^{3+}$  and  $Fe^{2+}$ ) ions at the tetrahedral and octahedral sites of the inverse spinel structure, respectively. Impedance spectroscopy measurements showed a discontinues variation in the temperature dependence of the sample's resistive behavior, indicating the appearance of semiconductor-metal-semiconductor like transitions between the temperature range of 293 and 373 K. A similar dual transition was also observed from the dielectric and conductivity measurements around the same temperature regions. The observed unusual transition is explained in term of the competitive effects among the hopping of localized/delocalized and short-range/long-range charge carriers present in the sample. Moreover, the prepared sample exhibits colossal dielectric permittivity ( $\sim 10^6$ ), reduced tangent loss ( $\sim 0.2$ ) and moderate conductivity ( $\sim 10^{-6}$  S cm $^{-1}$ ) values, making  $Fe_3O_4$  nanoparticles a potential candidate for electromagnetic absorbing materials.

Received 25th January 2022 Accepted 19th April 2022

DOI: 10.1039/d2ra00530a

rsc.li/rsc-advances

## 1. Introduction

Magnetite (Fe<sub>3</sub>O<sub>4</sub>) is a well-known ferrimagnetic material having an inverse spinel cubic structure with a space group of  $Fd\bar{3}m$ . In the inverse spinel structure, 1/3 of the Fe ions are located in the tetrahedral (A) sites as Fe<sup>3+</sup> while the rest are located in octahedral (B) sites as Fe<sup>2.5+</sup> in a closely packed array of oxygen atoms.1 Th ferrimagnetic nature is caused by the ferromagnetic sub-lattices (A- and B-sites) and their mutual antiferromagnetic interaction. Fe<sub>3</sub>O<sub>4</sub> has the highest value of magnetization, *i.e.*,  $M = 4.2 \mu_{\rm B}$  below the Curie temperature ( $T_{\rm c}$ = 850 K) and electrically is a good semiconducting material at room temperature and above. 1,2 However, on decreasing the temperature, the semiconducting behavior of Fe<sub>3</sub>O<sub>4</sub> changed into metallic character along with a decrease in the conductivity by two orders of magnitude due to a structural phase transition from cubic to monoclinic and charge-orbital ordering.3 This unusual transition usually occurs at  $T_v \approx 120$  K and is termed

a Verwey transition; however, this Verwey transition tempera-

In the last decade, efforts have been made to alter such unusual semiconductor to metal like conductivity transition in Fe<sub>3</sub>O<sub>4</sub> derived compounds (MFe<sub>2</sub>O<sub>4</sub>; where M is transition metal ions) at higher temperature without changing the crystal symmetry for the novel microwave switching applications in communication and sensing. The fundamental requirements for such applications are the creation of soft ferrimagnetic characteristics at room temperature, high electrical conductivity, reduced eddy current loss, and chemical stability.6 Several studies have been published on the magnetic and electrical properties of different Fe<sub>3</sub>O<sub>4</sub> derived compounds such as  $CoFe_2O_4$ ,  $^7MnFe_2O_4$ ,  $^8Co_{1.25}Fe_{1.75}O_4$ ,  $^9Ni_{1-x}Zn_xFe_2O_4$ ,  $^{10}Mg_{0.5}$  $Co_{0.5}Fe_2O_4$ , and  $Ni_{0.4}Cu_{0.2}Zn_{0.4}Fe_{2-x}Dy_xO_4$  spinel ferrite nanoparticles. 12 From these studies, we found that the magnetic exchange interactions and charge carriers hopping mechanism in these ferrites are considerably influenced by the cation distribution, surface spin structure, interparticle interactions, magnetocrystalline anisotropy and surface morphology. However, to understand the mechanism of semiconductor to metal transition (SMT) at higher temperature in the spinel ferrites, different concepts have been presented. Rahman et al.

ture  $(T_v)$  is found to be quite sensitive to the stoichiometry of the constituents in Fe<sub>3</sub>O<sub>4</sub>.<sup>4</sup> Although, the Verwey transition has a low operating temperature for most of the practical applications, it plays a vital role in the importance of iron based materials (ferrites) due to their promising applications in spintronics and nano-electronic switching devices.<sup>5</sup>

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 $<sup>\</sup>dagger$  Dedicated to M. Younas (1982–2021) for his contributions to the field of dielectric materials.

Paper

explained the presence of SMT at ~330 K in CoFe<sub>2</sub>O<sub>4</sub> nano-

particles by suggesting the dominance of direct cation-cation interaction (i.e., Fe3+-Fe2+) compared to cation-anion-cation interactions (i.e., Fe<sup>3+</sup>-O-Fe<sup>3+</sup> and Co<sup>2+</sup>-O-Co<sup>2+</sup>) at the B-sites.<sup>13</sup> Bastianello et al. observed a semiconducting behavior in the cobalt ferrite nanoparticles up to 400 °C due to hole hopping among the Co2+ and Co3+, while a SMT arises at higher temperature because of additional electron hopping among the Fe<sup>2+</sup> and Fe<sup>3+</sup> at the B-sites. 14 Younas et al. also found a similar type of SMT in NiFe<sub>2</sub>O<sub>4</sub> nanoparticles at around 358 K.<sup>15</sup> According to them, the existence of SMT is attributed to a competitive effect among the thermally stimulated localized and delocalized charge carriers, which could be further influenced by the magnetic spins order in doubly  $(e_g)$  and triply  $(t_{2g})$ degenerate electronic states at the B-sites. Later, Bhowmik et al. reported a dual transition in Ni<sub>1.5</sub>Fe<sub>1.5</sub>O<sub>4</sub> ferrite, where they found a semiconductor to metal transition (SMT) at around 373 K; however, on further increase in temperature, system returned back from metallic to semiconductor transition (MST) at around 413 K.16 They revealed that hopping of localized and long-range charge carriers governs the semiconducting behavior at low and high temperatures, respectively. While, the occurrence of metal-like behavior in the middle temperature region could be attributed to the hidden charge conduction phase which could be manifested depending on the coupling among the ferromagnetic spin order and electronic states along with the reconfiguration of charge carrier's conduction mechanism in the system. Similarly, Özdemir et al. confirmed a semiconductor-metal-semiconductor transition in pure CuFe<sub>2</sub>O<sub>4</sub> and CuO/CuFe<sub>2</sub>O<sub>4</sub> nanocomposites by impedance spectroscopy.<sup>17</sup> According to them, a metallic conduction is formed as a result of the delocalization of localized states and the formation of conducting channels. Moreover, the addition of CuO nanoparticles decreased the temperature at which metallic conductivity could be observed, which might be due to the composites' reduced cation and anion content. So far, none of the above-mentioned report obtained such unusual semiconductor-metal-semiconductor transition in other spinel ferrites. Moreover, the effects of cation distribution on the conduction mechanism along with the existence of metal like behavior between the two semiconductor states still need attention. Thus, in the present study, it was proposed to investigate the conductivity and dielectric properties of the nanostructured Fe<sub>3</sub>O<sub>4</sub> at higher temperatures (i.e., well above the Verwey transition temperature) for the probable occurrence of such type of transitions in the inverse spinel system.

In this work, Fe<sub>3</sub>O<sub>4</sub> nanoparticles were synthesized by a coprecipitation method and then investigated for their structural and magnetic properties along with the impedance spectroscopy measurements as a function of frequency  $(0.5-10^7 \text{ Hz})$ and temperature (293-373 K). Our impedance results confirmed the presence of semiconductor-metal-semiconductor transition in the prepared sample and also exhibited a colossal dielectric permittivity, reduced tangent loss and dissimilar conduction mechanism governed at high and low temperatures which make this material applicable for different technological applications.

## **Experimental**

Magnetite (Fe<sub>3</sub>O<sub>4</sub>) nanoparticles were synthesized via coprecipitation method. The stoichiometric amounts of iron sulfate heptahydrate [FeSO<sub>4</sub>·7H<sub>2</sub>O; Sigma-Aldrich; ≥99%] and iron chloride hexahydrate [FeCl<sub>3</sub>·6H<sub>2</sub>O; Sigma-Aldrich; ≥98%] were separately dissolved in the beakers containing 50 ml of deionized water using magnetic stirrer on the hot plate. Then, both solutions were mixed together in a beaker placed on a hot plate at 75 °C for 1 h. After an hour of stirring, ammonia (NH<sub>3</sub>) was added dropwise in the mixed solution until brownish solution turned into blackish. The sample was kept on the hot plate for further 1 h under same temperature and stirring conditions. Afterward, the beaker was moved from the hot plate and allowed to cool down to room temperature. The sample was then washed multiple times with deionized water and once with ethanol, and placed in a vacuum oven for 24 h at 70 °C for drying. Lastly, the dried powder was ground and compacted in the form of pellet by applying a pressure of 5 ton per cm<sup>2</sup> using hydraulic press and then sintered at 200 °C for 5 h.

Structural characterization was performed using X-ray diffractometer (ARL EQUINOX 3000) with CuKa X-ray source  $(\lambda = 1.54 \text{ Å})$ . The experimental XRD data was fitted with Rietveld refinement using FullProf software. The morphology of the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles was analyzed by high-resolution transmission electron microscopy (HRTEM) and selected area electron diffraction (SAED) using a JEOL JEM-2100F. Elemental analysis was conducted using scanning electron microscopy (VEGA3, TESCAN) equipped with an EDX detector (Oxford Instruments). At room temperature, the <sup>57</sup>Fe Mössbauer spectrum of the ground powder was collected at room temperature using <sup>57</sup>Co in Rh-matrix source in the transmission geometry. The Mössbauer data were fitted by assuming that all peaks were Lorentzian in shape. Magnetic measurements were made using a Quantum Design Inc. vibrating sample magnetometer (PPMS-VSM). To measure electrical/dielectric properties, the pelletized sample was connected on a probe with copper wires and silver paint. The probe was then connected to dielectric analyzer (Novocontrol Alpha N-Analyzer), which was connected to a computer through fully automated software WINDETA, which calculated different electrical parameters while varying the temperature via a resistive filament mounted inside the probe.

#### 3. Results and discussion

#### Structural analysis

X-ray diffraction (XRD) pattern of the pelletized Fe<sub>3</sub>O<sub>4</sub> sample is shown in Fig. 1. All of the obtained diffraction peaks are wellmatched with the JCPDS card no. 19-0629, confirming the formation of pure and single-phase spinel structure with space group  $Fd\bar{3}m$ . The XRD data was further analyzed by Rietveld refinement using the FullProf software. It can be seen from the figure that the experimentally obtained XRD patterns almost coincide with the calculated XRD patterns with an adequate value of goodness of fit ( $\chi^2 = 0.978$ ), showing the best fit to the experimental data. Here, the black colored circle represents the experimental data, the red colored line denotes the calculated

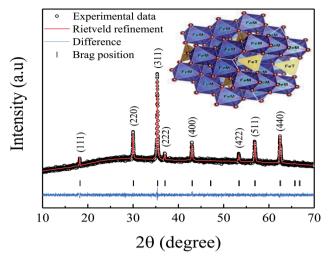


Fig. 1 X-ray diffraction pattern (experimental and Rietveld refinement) of the prepared  $Fe_3O_4$  sample. Inset shows a representative 3-D view of spinel  $Fe_3O_4$  sample.

intensities, the black vertical lines indicate the allowed Bragg's position, and the blue colored baseline indicates the difference among the calculated and experimental intensities. The

estimated values of lattice constant and crystallite size are found to be 8.340 Å and 12 nm, respectively. However, the obtained value of lattice constant is smaller than its bulk counterpart which is attributed to the high surface energy and surface tension, resulting in an overall shrinkage of the lattice. Moreover, to illustrate the crystal structure of the spinel Fe<sub>3</sub>O<sub>4</sub>, the crystallographic information file was used by employing the VESTA software. A representative 3-D view of Fe<sub>3</sub>O<sub>4</sub> sample is shown in the inset of figure. Here, the solid circles (red colored) indicate oxygen atoms, whereas the tetrahedral and octahedral cation sites are represented in yellow and blue colored regions, respectively. Fe atom is located in the middle of four and six oxygen atoms forming the corners of a regular tetrahedron and octahedron in the unit cell.

Fig. 2(a) shows the transmission electron microscopy (TEM) image for the prepared  $Fe_3O_4$  sample which confirmed the development of spherical nanoparticles. While, the inset of Fig. 2(a) displays the particle size distribution which were estimated from the TEM image using ImageJ software. The estimated value of particle size was found to be 11 nm, which is in good agreement with the XRD result. Fig. 2(b) shows the pattern of selected area electron diffraction (SAED) for the prepared nanoparticles which confirms the development of cubic phase, in accordance with the XRD pattern, by showing the bright

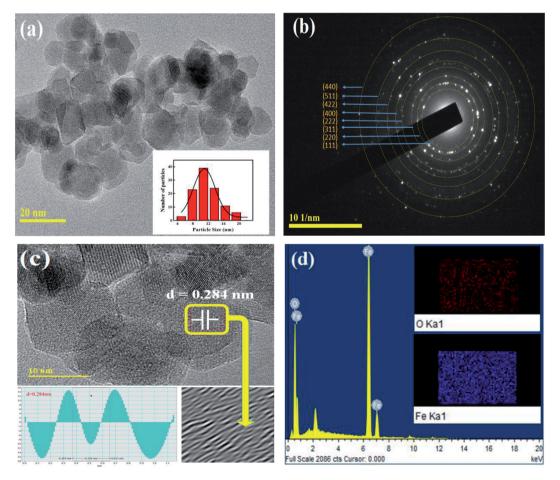


Fig. 2 (a) TEM micrograph, (b) SAED pattern, (c) HR-TEM image showing the respective plane, and (d) EDX spectrum for the prepared nanoparticles. Insets of (a) and (d) show the particle size distribution and elemental mapping analysis, respectively.

**Table 1** EDX analysis showing elemental composition for the prepared Fe $_3O_4$  nanoparticles

Element	Weight%	Atomic%		
O K Fe K Totals	24.46 75.54 100.00	53.06 46.94		

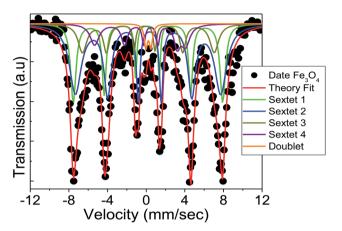


Fig. 3 Mössbauer spectrum of the prepared  ${\rm Fe_3O_4}$  nanoparticles measured at room temperature.

spots over the concentric rings. Fig. 2(c) shows a HR-TEM image of the prepared nanoparticles which indicates an interplanar spacing of 0.284 nm corresponding to the (220) plane of Fe<sub>3</sub>O<sub>4</sub>,<sup>19</sup> as confirmed by the line profile. Moreover, the energy dispersive X-ray spectroscopy (EDX) was employed to investigate the elemental composition of the prepared nanoparticles and the elemental mapping, as shown in Fig. 2(d). Here, the EDX spectrum and elemental mapping confirm the existence of Fe and O in the prepared nanoparticles without presence of any impurity. Table 1 shows the elemental compositions present in the prepared nanoparticles that agree with the experimental values, and the crystal structure exhibited a homogeneous chemical composition.

#### 3.2. Mössbauer spectroscopy

Mössbauer spectroscopy technique is commonly utilized to investigate the electronic, magnetic, and nuclear structure of iron-containing compounds. Fig. 3 shows the  $^{57}$ Fe Mössbauer spectra at room temperature for the prepared Fe<sub>3</sub>O<sub>4</sub> sample. The

hyperfine parameters are tabulated in Table 2. Here, the obtained spectrum was fitted with four well-resolved sextets and a doublet. The sextet with lower isomer shift (IS) is attributed to the tetrahedral (A) site, which contains only Fe<sup>3+</sup> ions while the other three sextets are believed to be due to the octahedral (B) site, which corresponds to the random distribution of both Fe3+ and Fe<sup>2+</sup> ions. The comparatively larger IS corresponding to the Fe ions are attributed to an effective mean charge of +2.5 at the Bsite. This usually happens due to fast charge transfer transition between the Fe<sup>3+</sup>-Fe<sup>2+</sup> centers at the same crystallographic site, which causes delocalization of spin electrons by super-exchange mechanism.20 Furthermore, in nanoparticles the surface layers are more active and have a strong effect on the cationic distribution. Due to these hopping and surface effects, the structural formula for  $Fe_3O_4$  can be written as  $[Fe^{3+}]_A[Fe_{2-x}^{2.5+}Fe_x^{3+}]_BO_4^{2-}$ instead of [Fe3+]A[Fe3+Fe2+]BO42-.21 Moreover, the emergence of a sextet verifies the magnetic behavior of the sample at room temperature while the doublet is assumed to be related to the nanoparticle's super-paramagnetic nature.

Quadrupole splitting (QS) is another critical Mössbauer parameter for defining the asymmetry of the charge distribution surrounding Fe ions. The strength of the quadrupole interaction is determined by the electric field gradient (EFG) generated by the nucleus's s-electron density. The EFG at the B-site could be a result of the nearest neighbours' deformed octahedral geometry, which results in a non-spherical charge distribution.<sup>21</sup> While, the negative QS values may be attributed to the Fe ion's oblate charge distribution.<sup>22</sup> It can be observed from Table 2 that the sign of QS changes from Fe<sup>3+</sup> to Fe<sup>2.5+</sup> in the octahedral B-site, which confirms a charge re-distribution by the surface modification of Fe<sub>3</sub>O<sub>4</sub>.

The cation distribution among the A- and B-sites may be determined using the area and intensity of the  $2^{\rm nd}$  and  $5^{\rm th}$  peaks in the normalized Mössbauer data, which are listed in Table 2. It can be observed that the tetrahedral A-site consists of about 32% of trivalent Fe ions and the B-site consists of a mixture of about 11% of trivalent and 45% of divalent Fe ions, while, some 9% of Fe<sup>3+</sup> ions reside on the surface. For stoichiometric magnetite, the area ratio of A-site to the B-site remains 0.5. However, in this study, we found that the area ratio of A-site to B-site comes out to be 0.567, which is slightly higher than a perfect stoichiometry. This usually happens due to the strong contribution of the surface layers, which has been observed from the Mössbauer data analysis. Hence, the stoichiometry of the Fe<sub>3</sub>O<sub>4</sub> sample can be written based on Mössbauer data as follows:

Table 2 Mössbauer parameters for the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles

H <sub>eff</sub> (kOe)	QS (mm s <sup>-1</sup> )	IS (mm s <sup>-1</sup> )	Width	Area (%)	Sites
479.63	0.068	0.26	0.66	32.15	A-site Fe <sup>3+</sup> (sextet-1)
466.46	-0.18	0.68	1.47	45	B-site Fe <sup>2+</sup> (sextet-2)
423.07	0.38	0.13	1.07	11.69	B-site Fe <sup>3+</sup> (sextet-3)
291.66	-1.11	0.13	1.11	9.03	Surface Fe <sup>3+</sup> (sextet-4)
_	0.52	0.33	0.40	2.13	Superparamagnetic (doublet)

 $[Fe^{3+}]_A[Fe_{2.91}^{2.5+}Fe_{0.09}^{3+}]_BO_4$ 

#### 3.3. Magnetic properties

Fig. 4(a) shows temperature-dependent magnetic measurements of the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles in zero-field (ZFC) and field-cooled (FC) modes using produced nanoparticles and a magnetic field of 50 Oe. The ZFC curve exhibits a broad peak with a maximum at  $T_{\rm B} = 122$  K, corresponding to the average blocking temperature  $(T_{\rm B})$  of nanoparticles. Above  $T_{\rm B}$ , the thermal stimulation energy overcomes the anisotropy energy barrier, causing the spins of the nanoparticles to oscillate between their two easy axis directions.23 However, the overlapping of ZFC and FC curves above  $T_{\rm B}$  specifies the presence of certain particle size distribution and/or interparticle interactions in the prepared nanoparticles (see Fig. 2(a)).23 Fig. 4(b) shows the hysteresis loop (M-H) of the prepared nanoparticles which was measured by applying a magnetic field of  $\pm 20$  kOe at room temperature. Here, a symmetric unsaturated hysteresis loop with a small coercive field  $(H_c)$  of 18 Oe is observed which shows a superparamagnetic behavior of the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles. Moreover, the maximum value of room temperature magnetization  $(M_{20kOe})$  for the prepared nanoparticles is 32 emu g<sup>-1</sup> which is obviously lower than that of the bulk Fe<sub>3</sub>O<sub>4</sub> (90 emu g<sup>-1</sup>) and other reported values for Fe<sub>3</sub>O<sub>4</sub> nanoparticles.  $^{24,25}$  Here, the smaller value of  $M_s$  for the prepared nanoparticles can be justified by the smaller particle size effect because a non-collinear spin arrangement occurs effectively at/ near the surface, resulting reduced magnetic moment of prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles.<sup>25</sup>

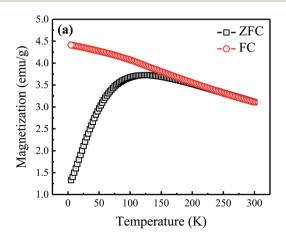
#### 3.4. Impedance spectroscopy

The electrical properties of the prepared  $Fe_3O_4$  nanoparticles were analyzed using a complex impedance spectroscopy. This technique is especially useful in characterizing the electrical properties of electro-ceramic materials like dielectric relaxation and conduction mechanism. Fig. 5(a and b) displays the complex impedance plane plots of the prepared nanoparticles

measured at different temperatures (293-373 K). Arrows in the impedance plane plot represents the increasing direction of frequency. Two semicircular arcs are clearly observed for the temperature range from 293 K to 333 K (see Fig. 5(a)); however, above 333 K, a single semicircular arc is only visible (see Fig. 5(b)). Here, the presence of different semicircular arcs represents different electro-active regions arise from the contribution of grains  $(G_s)$ , grain boundaries (GBs) and/or electrode effect (E<sub>s</sub>) having dissimilar relaxation times.<sup>15</sup> The intercept of these semicircular arcs at x-axis provides the total resistance of the sample. It can be seen from the figure that the diameter of the semicircular arcs reduces with increasing temperature and displays its minima around 313 K. With further increase in temperature, the diameter of the semicircular arcs begins to increase and shows its maxima around 343 K (see Fig. 5(a)). However, beyond 343 K, the diameter of semicircular arc begins to decrease again with increasing temperature (see Fig. 5(b)). Here, the temperatures at which the diameter of the semicircular arcs is minimum and maximum are labeled as semiconductor to metal (SMT) and metal to semiconductor (MST) like transition temperatures, respectively. To obtain a better understanding of these relaxation processes, we have fitted our experimental data with different equivalent circuit models involving a series and parallel combinations of resistance (R), capacitance (C), and constant phase element (Q)using ZView software. Generally, the constant phase element (CPE) is a deviation from the actual capacitative behavior indicating the presence of more than one relaxation phenomena with same relaxation time. The capacitance of CPE is calculated using the relation:

$$C = Q^{\frac{1}{n}} R^{\left(\frac{1-n}{n}\right)} \tag{1}$$

where n represents the dispersion parameter and the value of n is 1 for ideal capacitor and 0 for ideal resistor. Fig. 5(c and d) shows the fitting of experimental data recorded at 303 K using the equivalent circuits as shown in the insets of these figures along with their corresponding residuals. Here, the residual is



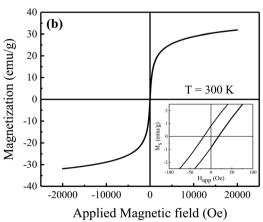
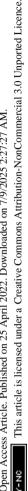


Fig. 4 (a) Zero-field cooled (ZFC) and field cooled (FC) magnetization measurements, and (b) magnetic hysteresis loop measured at room temperature for the prepared sample. Inset of (b) shows enlarged view of hysteresis loop at low field.



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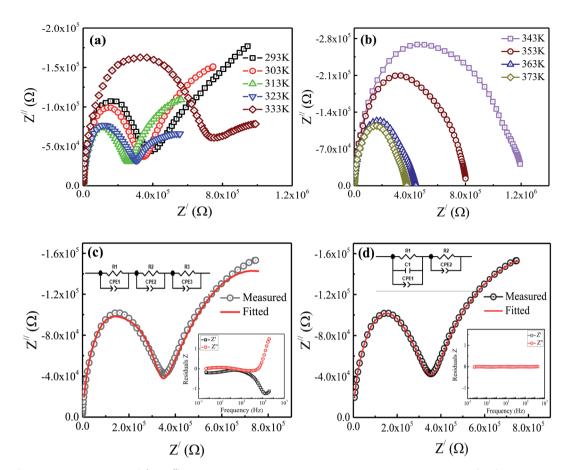


Fig. 5 (a and b) Impedance plane plots (Z' vs. Z'') of prepared sample measured at different temperatures, and (c, d) the fitting of experimental data recorded at 303 K using the equivalent circuits as shown in the insets of these figures along with their corresponding residuals.

an average deviation of the fitted curve from the measured data points. From these fitting procedures, a clear deviation in the fitting and measured data points is observed along with the poor residuals using the proposed circuit  $(R_1-CPE_1)(R_2 CPE_2$ )( $R_3$ - $CPE_3$ ), as shown in Fig. 5(c). Since, the series combination of RC circuits with CPE is typically a representation of grains  $(G_s)$ , grain boundaries (GBs), and electrode effect, which is not suitable here due to the poor quality of fit (see inset of Fig. 5(c)). However, the other combination of  $(R_1-C_1-\text{CPE}_1)(R_2-\text{CPE}_1)$ CPE<sub>2</sub>), as shown in Fig. 5(d), is found to be a good representation of the typical bulk impedance response with different ionic/electronic hopping conductors.26 Therefore, based on the obtained minimum residual value and good fit, we have fitted the obtained complex plane plots at different temperatures (293-373 K) using an equivalent circuit model of  $(R_1-C_1 CPE_1$ )( $R_2$ - $CPE_2$ ), as shown in Fig. 5(d). The estimated values of the fitting parameters for each temperature are listed in Table 3. Based on the obtained values of R and C, the semicircular arc at high frequency region is associated with the bulk counterpart of merged  $G_s$ -GBs with both capacitance  $C_1$  and CPE<sub>1</sub> lying within the geometrical values of  $G_s$  (10<sup>-11</sup> to 10<sup>-13</sup> F cm<sup>-1</sup>).<sup>27</sup> The possible reason for the merged  $G_s$ -GBs might be due to smaller particle size where  $G_s$  have high resistance despite the presence of multiple GBs around them. While the semicircular arcs in the impedance plane plots at low frequencies show the sample-

electrode effect with capacitance values comparable to those of the electrode effect (10<sup>-6</sup> to 10<sup>-7</sup> F cm<sup>-1</sup>).<sup>27</sup> Therefore, the second semicircular arc appearing in the impedance plot at lower frequency might be due to electrode effect  $(E_s)$ ; however, this low-frequency semicircular arc disappears above 333 K (see Fig. 5(b)). Beyond 333 K, we have fitted the obtained data using a parallel combination of  $R_1$ - $C_1$ -CPE<sub>1</sub> equivalent circuit model. We found that these single semicircular arcs have parameters comparable to the geometrical capacitance for  $G_s$ ; therefore, these single semicircular arcs are attributed to the contribution of  $G_{s}$ .

Fig. 6 shows the variations in the resistance of grains  $(G_s)$ and electrode effect  $(E_s)$  with temperature for the prepared nanoparticles. The inset of figure displays the variation in the total resistance  $(R_T = R_1 + R_2)$  with temperature. Here, the initial decreasing trend in the value of resistance with increasing temperature shows the semiconducting behavior. Above 313 K, an increasing trend in the  $G_s$  resistance is visible up to 343 K, which exhibits a metal-like behavior. However, the  $E_{\rm s}$  and  $R_{\rm T}$ resistance still show decreasing trends which might be due to increase in the mobility and decrease in the density of the hopping carriers with temperature. An increasing trend in the value of total resistance  $(R_T)$  is observed at 323 K as shown in the inset of figure. However, beyond 343 K, the values of  $G_s$  and  $R_T$ begin to decrease again with temperature, representing the

Table 3 Fitted parameters of Cole-Cole plots ( $R_1$ ,  $R_2$ ,  $R_T$ ,  $C_1$ , C and  $C_2$ ) and Jonscher's power law ( $\sigma_{dc}$ , A, n) for the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles

	Equivalent electrical circuit model					Power law			
T(K)	$R_1\left(\Omega\right)$	$C_1$ (F)	C(F)	$R_2\left(\Omega\right)$	$C_2$ (F)	$R_{\mathrm{T}}\left(\Omega\right)$	$\sigma_{ m dc}$	A	n
293	$4.34 \times 10^5$	$3.25 \times 10^{-12}$	$4.67 \times 10^{-12}$	$9.02  imes 10^5$	$2.94 \times 10^{-7}$	$1.32 \times 10^6$	$1.67 \times 10^{-6}$	$7.77 \times 10^{-10}$	0.777
303	$3.41 \times 10^5$	$3.20 \times 10^{-12}$	$5.20 \times 10^{-12}$	$8.32 \times 10^5$	$3.71 \times 10^{-7}$	$1.16 \times 10^6$	$1.97 \times 10^{-6}$	$8.33 \times 10^{-10}$	0.770
313	$2.53 \times 10^5$	$3.18 \times 10^{-12}$	$5.25 \times 10^{-12}$	$5.97 \times 10^{5}$	$4.09 \times 10^{-7}$	$8.50  imes 10^5$	$2.61\times10^{-6}$	$1.51 \times 10^{-9}$	0.728
323	$2.94\times10^{5}$	$3.14 \times 10^{-12}$	$7.88 \times 10^{-12}$	$3.98 \times 10^{5}$	$2.28 \times 10^{-7}$	$6.92  imes 10^5$	$2.40\times10^{-6}$	$2.35 \times 10^{-9}$	0.695
333	$7.31 \times 10^{5}$	$2.79 \times 10^{-12}$	$1.16 \times 10^{-11}$	$3.22  imes 10^5$	$2.85 \times 10^{-7}$	$1.05\times10^6$	$1.53 \times 10^{-6}$	$1.16 \times 10^{-9}$	0.737
343	$1.22\times10^6$	$2.55 \times 10^{-12}$	$1.14 \times 10^{-11}$	_	_	$1.22\times10^6$	$1.18\times10^{-6}$	$4.96 \times 10^{-10}$	0.789
353	$8.16  imes 10^5$	$2.45 \times 10^{-12}$	$5.84 \times 10^{-12}$	_	_	$8.16  imes 10^5$	$1.90\times10^{-6}$	$3.44 \times 10^{-10}$	0.813
363	$4.44  imes 10^5$	$2.40 \times 10^{-12}$	$3.51 \times 10^{-12}$	_	_	$4.44\times10^{5}$	$3.31 \times 10^{-6}$	$3.52 \times 10^{-10}$	0.809
373	$3.79\times10^5$	$2.28 \times 10^{-12}$	$2.65 \times 10^{-12}$	_	_	$3.79\times10^5$	$3.86 \times 10^{-6}$	$2.34 \times 10^{-10}$	0.836

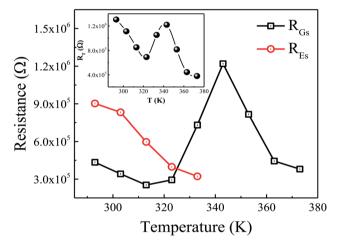


Fig. 6 Variation in the resistance of grains  $(R_{\rm Gs})$  and electrode  $(R_{\rm Es})$  with temperature. Inset shows the variation of total resistance  $(R_{\rm T})$  with temperature.

recurrence of semiconducting behavior. Generally, the coexistence of exchange and superexchange interactions is responsible for showing insulating, semiconducting, and metallic behavior in the metal oxides at different frequencies and temperatures. Moreover, below the Curie temperature, the presence of cations of the same elements with distinct valence states result in the metallic nature.15 In the present study, the coexistence of Fe<sup>3+</sup> and Fe<sup>2+</sup> are found to exist in the prepared nanoparticles, as inferred from the Mössbauer measurements. The electrostatic interaction among these different ionic states of metal ions (i.e., cation-anion-cation) causes a formation of relatively less stable doubly degenerate  $e_{\rm g}$  electrons and more stable triply degenerate  $t_{2g}$  electrons. <sup>28</sup> Therefore, to understand the observed semiconductor to metal (SMT) and metal to semiconductor (MST) like transitions at different temperatures, it is necessary to consider the energy of eg electrons as well as the potential for oxygen vacancies. For this, let  $E_k$  be the energy of the carriers participating in hopping (i.e.,  $e_g$  electrons), n be the number density of  $e_g$  electrons, and  $\phi$  be the potential of the oxygen vacancy. Mathematically,

$$n = n_{\rm o} \exp^{e\phi/k_{\rm B}T_{\rm c}} \tag{2}$$

where  $n_0$ , e,  $k_B$  and  $T_e$  are the number density of electrons at  $\phi =$ 0, charge on a single electron, Boltzmann constant and temperature of eg electrons.29 Here it is assumed that below 313 K, the carrier energy is smaller than the applied potential energy (i.e.,  $E_k < e\phi$ ) due to the presence of some electronic trap center and disorientation of surface/core spins. Thus, the hopping probability of e<sub>g</sub> electrons between Fe<sup>3+</sup>-O-Fe<sup>3+</sup> network at the B-site increases with increasing temperature up to 313 K, which in turn reduces the resistance of the sample and displays the semiconducting behavior. Above 313 K, the efficient conducting channels begin to appear with further increase in temperature, causing the delocalization of charges and alignment of surface/ core spins which satisfies the condition  $E_k > e\phi$ . These conducting channels in the form of Fe<sup>3+</sup>-Fe<sup>2+</sup> network facilitate the electron hopping thereby increasing the mobility of charge carriers and we observe a metal-like behavior up to 343 K. However, above 343 K, the hopping probability of eg electrons increases again due to increase in the conductivity caused by the un-trapped delocalized charges, which represent the recurrence of semiconducting behavior.

To better understand into whether the relaxation process is dominated by short-range or long-range charge carrier movement, Fig. 7(a-c) compares the normalized plots of the imaginary part of modulus (M'') and impedance (Z'') as a function of frequency for various representative temperatures. It can be seen from the figure that, within the available frequency window, only one peak is visible in both components of normalized M'' and Z'' at higher frequency region. At 303 K (lowtemperature semiconducting regime), a distinct mismatch between the two peaks is observed, indicating that charge carriers are localized and that the relaxation process is governed by short-range mobility of charge carriers.30 With the increase in temperature, the observed mismatch between the two peaks decreases at 323 K (intermediate-temperature metal-like regime) which suggests that the conduction process become less localized and translated to long-range mobility of charge carriers (see Fig. 7(b)). However, with increasing temperature, the mismatch between the M'' and Z'' becomes nearly same at 363 K (high-temperature semiconducting regime) as shown in Fig. 7(c), indicating the relaxation process is dominated by the long-range movement of charge carriers.30 Hence, the increase

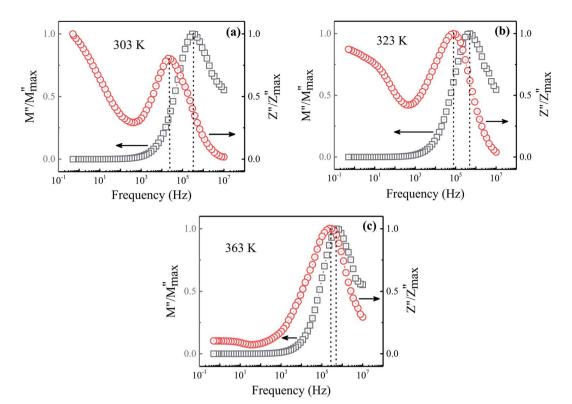


Fig. 7 Comparison of the imaginary parts of the impedance (Z') and modulus (M'') as a function of frequency for the prepared sample at (a) 303 K, (b) 323 K, and (c) 363 K.

of temperature promotes the long-range hopping movement of the charge carriers activated by the lattice oscillations. frequency-dependent at high frequency regions, which is in accordance with the Jonscher's power law:

#### 3.5. AC conductivity

Fig. 8(a) displays the temperature and frequency dependent behavior of AC conductivity ( $\sigma_{ac}$ ) for the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles. Here, the frequency-dependent behavior shows a typical trend where the conductivity values are weakly frequency-dependent at low frequency regions and strongly

$$\sigma_{\rm ac}(w,T) = \sigma_{\rm dc}(T) + A(T)\omega^{n(T)} \tag{3}$$

where w,  $\sigma_{\rm dc}$ , A and n are the angular frequency ( $w = 2\pi f$ ), dc conductivity (frequency-independent conductivity), strength of polarizability and slope of the frequency-dependent region (0.0  $\leq n \leq 1.0$ ), respectively.<sup>31</sup> We have fitted the measured data using eqn (3) and found an agreement among the experimental

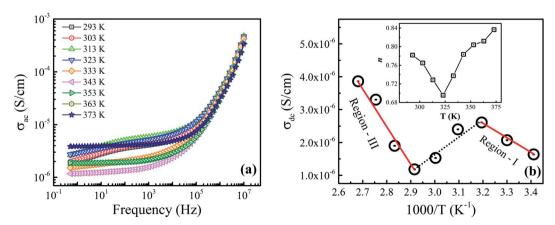


Fig. 8 (a) Variation of frequency-dependent ac conductivity measured at different temperatures, and (b) the Arrhenius plots of the dc conductivity for the prepared sample. Solid lines show the linear fit to the experimental data. Inset of (b) shows the variation of slope parameter *n* with temperature.

and fitted data within the frequency region (i.e.,  $10^2$  to  $10^7$  Hz). The obtained fitted parameters at different temperatures are tabulated in Table 3. The temperature-dependent dc conductivity ( $\sigma_{dc}$ ) behavior in Fig. 8(b) shows three thermal activated conductivity regions. The  $\sigma_{dc}$  curves transform from semiconductor behavior (region-I: increase of  $\sigma_{dc}$ ) to metal-like behavior (region-II: decrease of  $\sigma_{dc}$ ) at T=313 K with increasing temperature. Afterward, with the further increase in temperature, the metal-like behavior is transformed into second semiconductor behavior (region-III: increase of  $\sigma_{dc}$ ) above T = 343 K. Here, the observed metal-like behavior in the prepared sample is not considered as a real metallic behavior because of the fact that the  $\sigma_{ac}$  behavior of the prepared sample follows the Jonscher's power law.9 Thus, the observed metal-like behavior (region-II) at intermediate temperature range (313-343 K) might be due to the presence of trapped conducting charge carriers, which can be evident from the correlation among the disordered surface spins and electronic trap centers at the Bsites. Moreover, in the semiconducting regions (i.e., region-I & III), the linear trends of  $\sigma_{dc}$  obey Arrhenius equation as follows:

$$\sigma_{\rm dc} = \sigma_{\rm o} \exp^{(-E_{\rm a}/k_{\rm B}T)} \tag{4}$$

where  $\sigma_0$  is the pre-exponential factor,  $E_a$  is the activation energy,  $K_{\rm B}$  is the Boltzmann's constant and T is the absolute temperature. 32 The activation energies  $(E_a)$  are found to be 0.262 eV and 1.019 eV in region-I and region-III, respectively. Here, the obtained values of  $E_a$  suggest the dominance of hopping of electrons and hole hopping process along with polaron conduction at the low- and high-temperature regimes, respectively.17 Hence, the activation energies estimated for the prepared sample predict both hopping and polaronic conduction mechanisms among the localized sites. Moreover, the inset of Fig. 8(b) displays the variation of slope exponent (n) with temperature. It can be seen that the value of *n* decreases with increasing temperature up to 323 K and then it begins to increase. Here, the minimum value of n is obtained in the intermediate temperature region (region-II) which might be associated to the charge carrier's delocalized character in comparison to charge localization at low (region-I)

and high (region-III) temperatures. However, the observed variation in n(T) reveals that charge conduction in the prepared sample is governed by the overlapping large polaron tunneling (OLPT) mechanism.<sup>33</sup>

#### 3.6. Dielectric properties

Fig. 9(a) shows the behavior of real part of dielectric permittivity  $(\varepsilon')$  measured at different temperatures. The graph shows the typical permittivity vs. frequency pattern where dielectric permittivity values are higher at low frequency region and decreases as frequency increases at all temperatures and displays a constant behavior at higher frequencies. Dispersion in dielectric values could be understood using Maxwell-Wagner polarization model in accordance with Koop's theory.34,35 It is proposed that ferrites are composed of conducting  $G_s$ , separated by resistive GBs. At low frequencies, charges transport via  $G_{\rm s}$  to GBs and creating a local lattice distortion by asymmetric charge distribution which moves along the applied field.36 Such type of polarization is known as space charge polarization. But, as frequency increases, this slowly moving lattice distortion (space charge polarization) cannot follow the higher applied field and lag behind, resulting in the decrease of dielectric permittivity values with the increase in frequency. Moreover, the value of dielectric permittivity initially increases as temperature rises to 313 K due to thermally activated dipoles, increasing the electron exchange interaction which results in the increase of dielectric permittivity. Here, the obtained value of dielectric permittivity at room temperature is found to be comparatively higher than the reported ones.37-40 The reason for such a high dielectric permittivity is that the prepared sample has electrical inhomogeneity caused by the  $G_s$  and GBs effect. Above 313 K, a decrease in the value of dielectric permittivity is observed due to the delocalization of conducting channels. However, above 343 K, the value of dielectric permittivity begins to increase again due to the oxygen ion hopping at relatively higher temperatures, supporting our earlier MST discussion.

Fig. 9(b) shows the variation of dielectric tangent loss (tan  $\delta$ ) vs. frequency for the prepared Fe<sub>3</sub>O<sub>4</sub> nanoparticles measured at

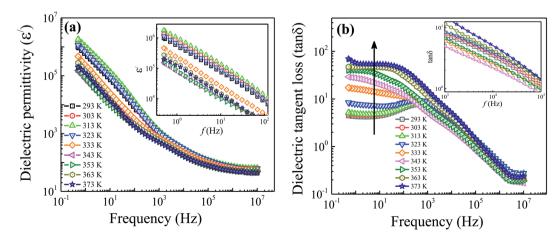


Fig. 9 Variation of the (a) real part of dielectric permittivity and (b) dielectric tangent loss with frequency measured at different temperatures. Insets of each part show the enlarged view of dielectric permittivity and dielectric tangent loss at low and high frequency regimes, respectively.

Paper

different temperatures. It can be seen that, for all temperatures, concluded that the colossal dielectric permittivity, reduced tangent loss, high conductivity and moderate magnetization values make Fe<sub>3</sub>O<sub>4</sub> nanoparticles as a potential candidate for

the value of tangent loss decreases with increasing frequency followed by a peak behavior appearing in the frequency range of 10<sup>2</sup> to 10<sup>3</sup> Hz. This peak behavior usually appears when hopping frequency matches the frequency of external applied field.41 Moreover, it can be seen from the figure that the tan  $\delta$  plot exhibit two distinct features. At low frequency region (0.5–10<sup>3</sup> Hz), the tan  $\delta$  values increase linearly with temperature as indicated by arrow-head. The electrode effect is predominant in our sample at low frequency up to 343 K and then vanished at higher temperatures, as discussed in the impedance section. Therefore, an increasing value of tan  $\delta$  in the low frequency region might be due to the fact that energy is consumed in overcoming the electrode effect. However, the increasing trend of tan  $\delta$  values above 343 K is explained by a drift of surface-spins and appearance of increased conductive channels. While, at high frequency region  $(10^3-10^7)$  Hz), one can see from the inset of figure that the value of tan  $\delta$  initially increases as temperature rises up to 313 K. This observed increase in tan  $\delta$  is accredited to the increase in thermally activated charge carriers showing the semiconducting behavior, as discussed earlier. However, above 313 K (i.e., SMT temperature), the tan  $\delta$  value is found to decrease due to the delocalization of charge carriers. Since, the movement or flipping of delocalized conductive channels with AC-field is easier; therefore, less energy is dissipated which results in the decrease of tan  $\delta$  values till 343 K. Afterwards, the value of tan  $\delta$  begins to increase again with temperature which is explained by the increased conductivity values at high temperatures. Here, the obtained values of tan  $\delta$  for the prepared sample are <0.18 at high frequencies (10<sup>7</sup> Hz) and found to be comparatively small in comparison to the literature values. 37,38 Hence, the reduced value of tan  $\delta$  for the prepared sample along with a high dielectric permittivity making these sample interesting for the electromagnetic absorbing material.

#### Conclusions

In summary, the existence of novel semiconductor-metalsemiconductor (SMST) type of transition has been investigated using impedance spectroscopy technique and we observed a semiconductor-metal transition at 313 K and a metal-semiconductor transition at 343 K in the Fe<sub>3</sub>O<sub>4</sub> nanoparticles. Here, the dominating cause for the existence of SMST is described by the coexistence of exchange and superexchange mechanisms and conductivity on the basis of doubly degenerate  $e_g$  levels and relatively more stable triply degenerate  $t_{2g}$  levels. Moreover, we found that both short-range and long-range movements of charge carriers governs the conduction process in the sample. While the presence of metal-like behavior at intermediate temperature could be a result of the semiconductor state transitioning from short-range to long-range conduction at low and high temperatures, respectively. The prepared sample also exhibits a colossal dielectric permittivity at room temperature compared to the values reported for other spinel ferrite systems. The origin of such high dielectric permittivity lies in the sample's electrical inhomogeneity caused by the  $G_s$  and GBs effect. Hence, from this work, it can be

electromagnetic absorbing material. However, to understand whether the SMST transition found in Fe<sub>3</sub>O<sub>4</sub> nanoparticles is an intrinsic/reversible properties of the system, more experiments are in progress.

### Conflicts of interest

There are no conflicts to declare.

## Acknowledgements

Authors appreciate the financial support provided by the Higher Education Commission (HEC), Pakistan, via research grant no. TDF-044/2017.

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